

LIST OF REFERENCES CITED BY APPLICANT (Use several sheets if necessary)

ATTY. DOCKET NO. 450100-04886	SERIAL NO. 10/760,081	
APPLICANT Fumitaka KAWATE et al.		
FILING DATE January 19, 2004	GROUP 2615	

EXAMINER INITIAL	-	DOCUMENT NUMBER	DATE	NAME		CLASS	SUBCLASS	FILING DATE I
/M.D./	AA	2003 0138100	07/24/03	Ishizaka et	al	***************************************		747.07.12.110
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Sheet I of I

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				U.S	. PATENT	DOCUMENTS			
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/M.D./	AJ			09/27/02	Japan				Abstract
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	AO Apple Computer, Inc., Inside Macintosh: Quick Time (Japanese Ed.), Addison-Wesley Publishing Co., Oct								g Co., Oct. 1993
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